















**ESD** 

TVS

MOS

LDO

Diode

Sensor

DC-DC

# **Product Specification**

Domestic Part Number	IRF7301
<ul><li>Overseas Part Number</li></ul>	IRF7301
▶ Equivalent Part Number	IRF7301





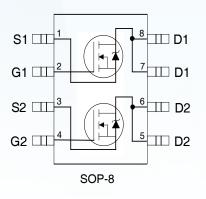
## Description

The SOP-8 has been modified through a customized leadframe for enhanced thermal characteristics and multiple-die capability making it ideal in a variety of power applications. With these improvements, multiple devices can be used in an application with dramatically reduced board space. The package is designed for vapor phase, infra red, or wave soldering techniques. Power dissipation of greater than 0.8W is possible in a typical PCB mount application.

- Generation V Technology
- Ultra Low On-Resistance
- Dual N-Channel Mosfet
- Surface Mount
- Available in Tape &Reel
- Dynamic dv/dt Rating
- Fast Switching
- Lead-Free

#### **Features**

- VDS (V) = 20V
- RDS(ON) < 40m $\Omega$  (VGS = 4.5V)
- RDS(ON) < 50m $\Omega$  (VGS = 2.7V)



## **Absolute Maximum Ratings**

	Parameter	Max.	Units
I <sub>D</sub> @ T <sub>A</sub> = 25°C	10 Sec. Pulsed Drain Current, V <sub>GS</sub> @ 4.5V	5.7	А
I <sub>D</sub> @ T <sub>A</sub> = 25°C	Continuous Drain Current, V <sub>GS</sub> @ 4.5V	5.2	Α
I <sub>D</sub> @ T <sub>A</sub> = 70°C	Continuous Drain Current, V <sub>GS</sub> @ 4.5V	4.1	А
I <sub>DM</sub>	Pulsed Drain Current ①	21	Α
P <sub>D</sub> @T <sub>A</sub> = 25°C	Power Dissipation	2.0	W
	Linear Derating Factor	0.016	W/°C
V <sub>GS</sub>	Gate-to-Source Voltage	± 12	V
dv/dt	Peak Diode Recovery dv/dt ②	5.0	V/ns
$T_{J,}T_{STG}$	Junction and Storage Temperature Range	-55 to + 150	℃

#### **Thermal Resistance Ratings**

	Parameter	Тур.	Max.	Units
$R_{\theta JA}$	Maximum Junction-to-Ambient⊕		62.5	°C/W



# Electrical Characteristics @ T<sub>J</sub> = 25°C (unless otherwise specified)

	Parameter	Min.	Тур.	Max.	Units	Conditions
V <sub>(BR)DSS</sub>	Drain-to-Source Breakdown Voltage	20			V	$V_{GS} = 0V, I_{D} = 250\mu A$
$\Delta V_{(BR)DSS}/\Delta T_J$	Breakdown Voltage Temp. Coefficient		0.044		V/°C	Reference to 25°C, I <sub>D</sub> = 1mA
D	Static Drain-to-Source On-Resistance			40	mo	V <sub>GS</sub> = 4.5 V, I <sub>D</sub> = 2.6A ③
R <sub>DS(ON)</sub>	Static Dialit-to-Source Off-Nesistance			50	11152	$V_{GS} = 2.7 V, I_D = 2.2 A$ ③
$V_{GS(th)}$	Gate Threshold Voltage	0.70			V	$V_{DS} = V_{GS}$ , $I_D = 250\mu A$
<b>g</b> fs	Forward Transconductance	8.3			S	V <sub>DS</sub> = 15V, I <sub>D</sub> = 2.6A
I <sub>DSS</sub>	Drain-to-Source Leakage Current			1.0	μΑ	V <sub>DS</sub> = 16V, V <sub>GS</sub> = 0V
				25		V <sub>DS</sub> = 16V, V <sub>GS</sub> = 0V, T <sub>J</sub> = 125 °C
	Gate-to-Source Forward Leakage			100	A	V <sub>GS</sub> = 12V
lgss	Gate-to-Source Reverse Leakage			-100	nA	V <sub>GS</sub> = - 12V
Qg	Total Gate Charge			20		I <sub>D</sub> = 2.6A
Q <sub>gs</sub>	Gate-to-Source Charge			2.2	nC	V <sub>DS</sub> = 16V
Q <sub>gd</sub>	Gate-to-Drain ("Miller") Charge			8.0		V <sub>GS</sub> = 4.5V, See Fig. 6 and 12 ③
t <sub>d(on)</sub>	Turn-On Delay Time		9.0			V <sub>DD</sub> = 10V
t <sub>r</sub>	Rise Time		42		ns	I <sub>D</sub> = 2.6A
t <sub>d(off)</sub>	Turn-Off Delay Time		32			$R_G = 6.0\Omega$
t <sub>f</sub>	Fall Time		51			R <sub>D</sub> = 3.8Ω, See Fig. 10 ③
L <sub>D</sub>	Internal Drain Inductance		4.0		nН	
L <sub>S</sub>	Internal Source Inductance		6.0			Between lead tip and center of die contact
C <sub>iss</sub>	Input Capacitance		660			V <sub>GS</sub> = 0V
Coss	Output Capacitance		280		pF	V <sub>DS</sub> = 15V
C <sub>rss</sub>	Reverse Transfer Capacitance		140			f = 1.0MHz, See Fig. 5

# Source-Drain Ratings and Characteristics

	Parameter	Min.	Тур.	Max.	Units	Conditions
Is	Continuous Source Current					MOSFET symbol
	(Body Diode)			2.5	Α	showing the
I <sub>SM</sub>	Pulsed Source Current				_ A	integral reverse
	(Body Diode) ①	İ		21		p-n junction diode.
$V_{SD}$	Diode Forward Voltage			1.0	V	T <sub>J</sub> = 25°C, I <sub>S</sub> = 1.8A, V <sub>GS</sub> = 0V ③
t <sub>rr</sub>	Reverse Recovery Time		29	44	ns	$T_J = 25^{\circ}C$ , $I_F = 2.6A$
$Q_{rr}$	Reverse RecoveryCharge		22	33	nC	di/dt = 100A/µs ③
ton	Forward Turn-On Time	Intr	Intrinsic turn-on time is negligible (turn-on is dominated by L <sub>S</sub> +L <sub>D</sub> )			

#### Notes:

- ① Repetitive rating; pulse width limited by max. junction temperature. ( See fig. 11 )
- $\begin{tabular}{l} @\ I_{SD} \leq 2.6A,\ di/dt \leq 100A/\mu s,\ V_{DD} \leq V_{(BR)DSS}, \\ T_{J} \leq 150 ^{\circ}C \end{tabular}$
- 4 Surface mounted on FR-4 board,  $t \leq 10 sec.$



## TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)

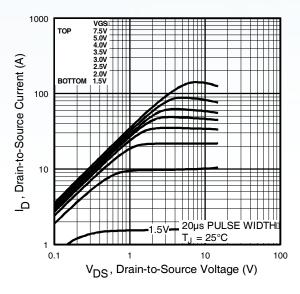


Fig 1. Typical Output Characteristics

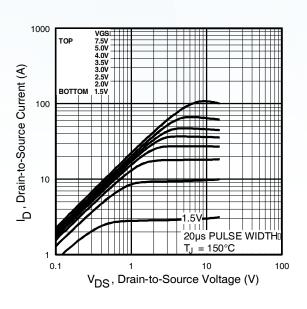


Fig 2. Typical Output Characteristics

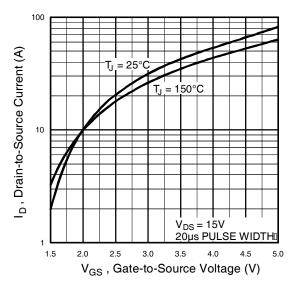
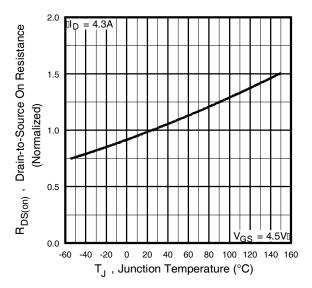


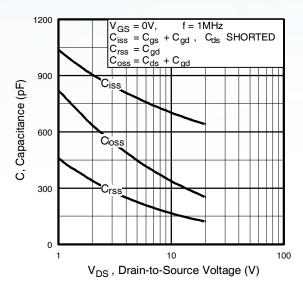
Fig 3. Typical Transfer Characteristics



**Fig 4.** Normalized On-Resistance Vs. Temperature



## TYPICAL CHARACTERISTICS (25 °C, unless otherwise noted)



**Fig 5.** Typical Capacitance Vs. Drain-to-Source Voltage

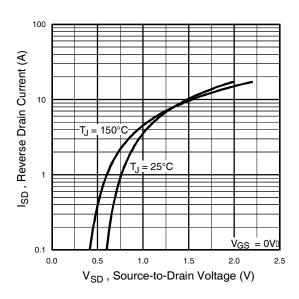
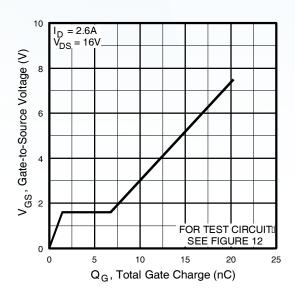


Fig 7. Typical Source-Drain Diode Forward Voltage



**Fig 6.** Typical Gate Charge Vs. Gate-to-Source Voltage

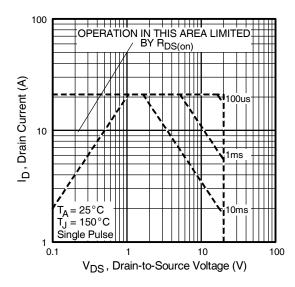


Fig 8. Maximum Safe Operating Area



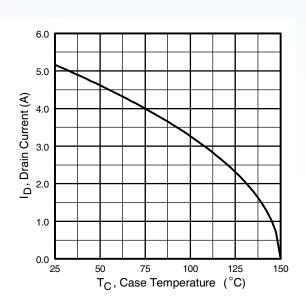


Fig 9. Maximum Drain Current Vs.
Ambient Temperature

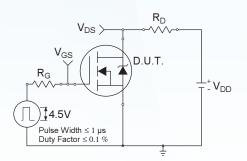


Fig 10a. Switching Time Test Circuit

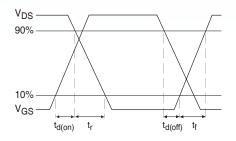


Fig 10b. Switching Time Waveforms

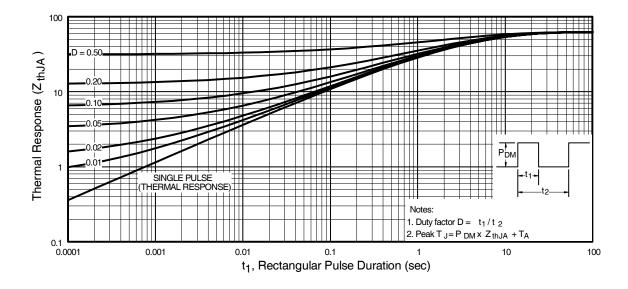
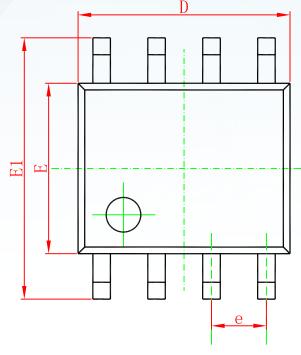
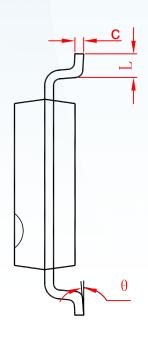


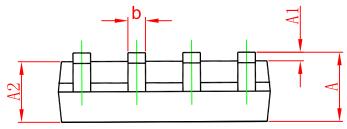
Fig 11. Maximum Effective Transient Thermal Impedance, Junction-to-Ambient







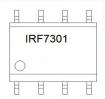




Cymhal	Dimensions In	Millimeters	Dimensions In Inches		
Symbol	Min	Max	Min	Max	
А	1.350	1.750	0.053	0.069	
A1	0.100	0.250	0.004	0.010	
A2	1.350	1.550	0.053	0.061	
b	0.330	0.510	0.013	0.020	
С	0.170	0.250	0.006	0.010	
D	4.700	5.100	0.185	0.200	
Е	3.800	4.000	0.150	0.157	
E1	5.800	6.200	0.228	0.244	
е	1.270	1.270(BSC)		O(BSC)	
L	0.400	1.270	0.016	0.050	
θ	0°	8°	0°	8°	



# Marking



# **Ordering information**

Order code	Package	Baseqty	Deliverymode
IRF7301	SOP-8	3000	Tape and reel



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